1. Scope

The present specifications shall apply to an RD2A.

2. Outline

	Туре	Silicon Diode			
	Structure	Resin Molded			
Applications High Frequency Rectification		High Frequency Rectification			
3. F	. Flammability UL94V-0(Equivalent)				
8. Flammability UL94V-0(Equivalent)					

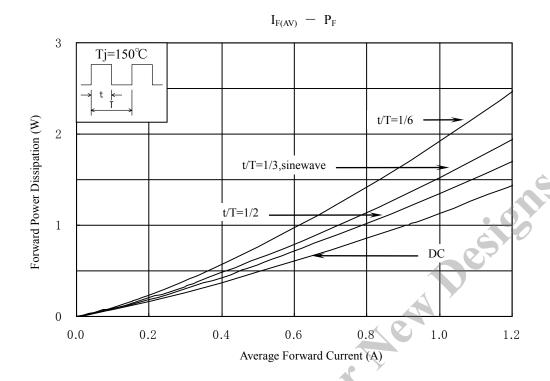
4. Absolute maximum ratings

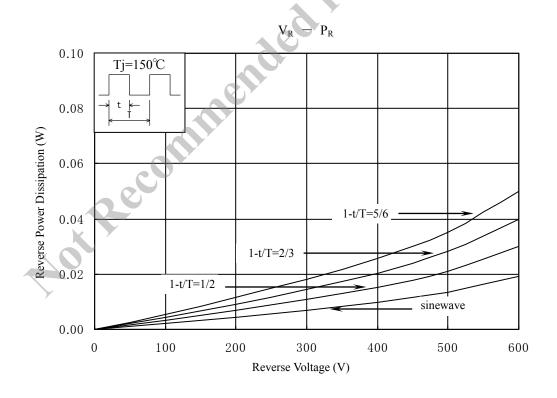
No.	Item	Symbol	Unit	Rating	Conditions
1	Transient Peak Reverse Voltage	V _{RSM}	V	600	
2	Peak Reverse Voltage	V_{RM}	V	600	
3	Average Forward Current	I _{F(AV)}	A	1.2	Refer to Derating of 7
4	Peak Surge Forward Current	I_{FSM}	A	30	10msec. Half sinewave, one shot
5	I ² t Limiting Value	I^2t	A^2s	4.5	1msec≦t≦10msec
6	Junction Temperature	T_{j}	$^{\circ}$	-40~+150	
7	Storage Temperature	T_{stg}	$^{\circ}$	-40~+150	5

5. Electrical characteristics

No.	Item	Symbol	Unit	Value	Conditions
1	Forward Voltage Drop	$V_{\rm F}$	V	1.55 max.	I _F =1.2A
2	Reverse Leakage Current	I _R	uА	50 max.	$V_R = V_{RM}$
3	Reverse Leakage Current Under High Temperature	$H \cdot I_R$	uA	100 max.	$V_R = V_{RM}, T_j = 150$ °C
4	Reverse Recovery Time	$t_{\rm tr}$ l	ns	50 max.	I _F =I _{RP} =100mA 90% Recovery point, T _j =25°C
4		t _{rr} 2	ns	35 max.	I _F =100mA, I _{RP} =200mA 75% Recovery point, T _j =25°C
5	Thermal Resistance	R _{th(j-l)}	°C/W	12 max.	Between Junction and Lead
Agi Re					

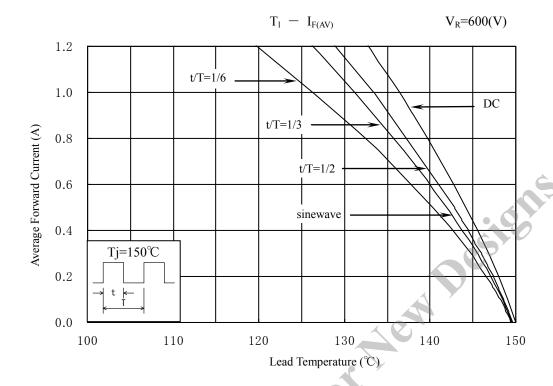
6. Characteristics

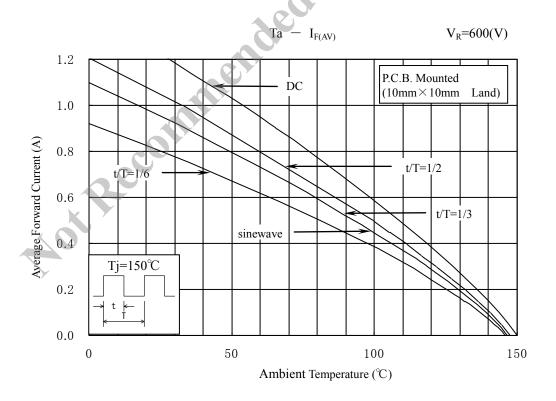




'041117 SSA-04577 3/7

7. Derating

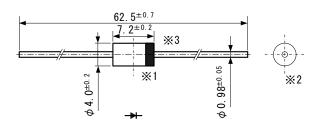




'041117 SSA-04577 4/7

8. Package information

8-1 Package type, physical dimensions and material



- The allowance position of Body against the center of whole lead wire is 0.5mm(max.)
- The centric allowance of lead wire against center of physical body is 0.3mm(max.)
- The burr may exit up to 2mm from the body of lead

Dimensions in mm

8-2 Appearance

The body shall be clean and shall not bear any stain, rust or flaw.

8-3 Marking

- Type number RD2A
- Lot number 1

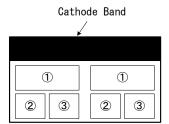
First digit: Last digit of Year

Second digit: Month

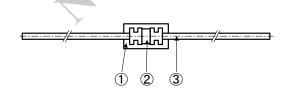
From 1 to 9 for Jan. to Sep.

O for Oct., N for Nov., and D for Dec.

- Lot number 2 (ten days)
 - Top of the month
 - Middle of month : End of month



9. Internal structure diagram



No.	Name of part	Materials
1	Plastic body	Epoxy Resin
2	Chip	Silicon
3	Leads	Solder Dipped Silver plated copper wire

10. Reliability

No.	Item	Rating	Conditions	
1	Thermal Fatigue Test	5000 cycles	⊿Tj=100°C	
2	High Temperature Reverse Bias Test	1000 hours	Ta=150°C, V _R =V _{RM} (Half sine wave)	
3	Humidity Reverse Bias Test	500 hours	Ta=85°C, R.H.=85%, $V_R=V_{RM}\times 0.8(D.C.)$	
4	High Temperature Storage Test	1000 hours	Ta=150°C	
5	Moisture Resistance Test	1000 hours	Ta=85℃, 85%R.H	
6	Thermal Shock Test	100 cycle	Ice-water(5min.) ~ R.T.(20sec.) ~ Boiling-water(5min.)	
7	Temperature Cycle Test	100 cycle	-40°C(30min.) ~ +150°C(30min.)	
8	Pressure Cooker Test	96 hours	2.03×10 ⁵ Pa, 100%R.H., Unsaturated equipment	
9	Resistance to Soldering Heat Test	10 sec.	260±5°C, Dipping up to 1.5mm form case	
9		3.5 sec.	380±5℃, Using soldering iron	
10	Solderability Test	95%	$245\pm5^{\circ}\text{C}$, $5\pm0.5\text{sec.}$, Using rosin flux	
11	Lead Bend Test	2 cycles		
12	Lead Pull Test	10 sec.	Apply EIAJ ED-4701 A-111	
13	Lead Twist Test	2 times		
14	Drop Test	10 times	Naturally drop from 1m height on maple plate	

Acceptance Criteria

(1)Item No.1~9 The product shall meet the electrical specifications in paragraph 5

after being exposed to normal temperature for less than 24 hours in 2 hours or more

(2)Item No.10 The product shall meet the rating.

(3)Item No.11~14 There shall be no trouble in testing and the electrical characteristics in paragraph 5 shall be met.

'041117 SSA-04577 6/7

11. Cautions and warnings

- Application and operation examples described in this document are quoted for the sole purpose of reference for the use of
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 Please return to us this document with your signature(s) or seal(s) prior to the use of the products herein.
 When considering the use of Sanken products in the applications where higher reliability is required (transportation).

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 - In addition, it should be noted that since power devices or IC's including power devices have large self-heating value, the degree of derating of junction temperature (Tj) affects the reliability significantly.
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'041117 SSA-04577 7/7